

Search Notes

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EDMUND H. LEE

Applicant(s)/Patent under
Reexamination

TANAKA ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
UPDATED		5/25/2005	EHL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
264	248,250	5/25/2005	EHL
	255		
	279.1		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR